

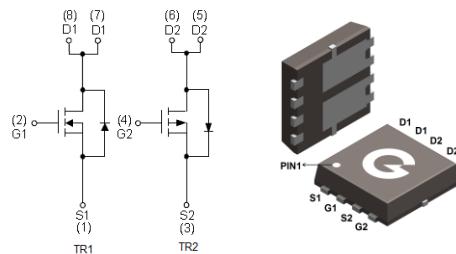
Features

- Complementary P + N channel
- Advanced trench technology
- Exceptional on-resistance and maximum DC current capability

HF

Mechanical Data

- Case: PDFN3x3-8LC
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208


PDFN3x3-8LC

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL2038D-3DL8	PDFN3x3-8LC	5000 pcs / Tape & Reel	2038D

Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Q1	Q2	Unit
Drain-to-Source Voltage	V_{DSS}	20	-20	V
Gate-to-Source Voltage	V_{GSS}	± 12	± 12	V
Continuous Drain Current ($T_A = 25^\circ\text{C}$) ^{*1}	I_D	4.7	-3.3	A
Continuous Drain Current ($T_A = 70^\circ\text{C}$) ^{*1}		3.7	-2.6	A
Pulsed Drain Current ($t_p = 10\mu\text{s}$, $T_A = 25^\circ\text{C}$)	I_{DM}	20	-15	A
Single Pulse Avalanche Energy ^{*3}	E_{AS}	2	2	mJ
Power Dissipation ($T_A = 25^\circ\text{C}$) ^{*1}	P_D	2.1		W
Operating Junction Temperature Range	T_J	$-55 \sim +150$		°C
Storage Temperature Range	T_{STG}	$-55 \sim +150$		°C

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	-	8	°C/W
Thermal Resistance Junction-to-Air ^{*1}	$R_{\theta JA}$	-	-	60	°C/W

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper

Electrical Characteristics-Q₁ (@ T_A = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	20	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20V, V _{GS} = 0V	-	-	1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±12V, V _{DS} = 0V	-	-	±100	nA
On Characteristics						
R _{DSON}	Drain-Source On-resistance ^{*2}	V _{GS} = 4.5V, I _D = 3A	-	-	65	mΩ
		V _{GS} = 2.5V, I _D = 2A	-	-	85	mΩ
V _{Gsth}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	0.5	0.9	1.2	V
R _G	Gate Resistance	V _{GS} = 0V, f = 1MHz	-	17	-	Ω
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{GS} = 0V V _{DS} = 10V f = 1.0MHz	-	188	-	pF
C _{OSS}	Output Capacitance		-	28	-	
C _{RSS}	Reverse Transfer Capacitance		-	22	-	
Switching Characteristics						
t _{d(ON)}	Turn-on Delay Time ^{*4}	V _{DD} = 10V V _{GS} = 4.5V I _D = 1A R _G = 6Ω	-	5	-	ns
t _r	Turn-on Rise Time ^{*4}		-	8.5	-	
t _{d(OFF)}	Turn-Off Delay Time ^{*4}		-	11	-	
t _f	Turn-Off Fall Time ^{*4}		-	3	-	
Q _G	Total Gate-Charge	V _{DD} = 10V V _{GS} = 4.5V I _D = 3.6A	-	3.3	-	nC
Q _{GS}	Gate to Source Charge		-	0.8	-	
Q _{GD}	Gate to Drain (Miller) Charge		-	0.6	-	
Source-Drain Diode Characteristics						
V _{SD}	Diode Forward Voltage ^{*2}	I _F = 1A, V _{GS} = 0V	-	-	1.2	V

Electrical Characteristics-Q₂ (@ T_A = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = -250μA	-20	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -20V, V _{GS} = 0V	-	-	-1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±12V, V _{DS} = 0V	-	-	±100	nA
On Characteristics						
R _{DSON}	Drain-Source On-resistance ^{*2}	V _{GS} = -4.5V, I _D = -1.5A	-	-	140	mΩ
		V _{GS} = -2.5V, I _D = -1.1A	-	-	180	mΩ
V _{Gsth}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250μA	-0.4	-0.6	-1.0	V
R _G	Gate Resistance	V _{GS} = 0V, f = 1MHz	-	40	-	Ω
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{GS} = 0V V _{DS} = -10V f = 1.0MHz	-	199	-	pF
C _{OSS}	Output Capacitance		-	29	-	
C _{RSS}	Reverse Transfer Capacitance		-	22	-	
Switching Characteristics						
t _{d(ON)}	Turn-on Delay Time ^{*4}	V _{DD} = -10V V _{GS} = -4.5V I _D = -1A R _G = 5Ω	-	11	-	ns
t _r	Turn-on Rise Time ^{*4}		-	5	-	
t _{d(OFF)}	Turn-Off Delay Time ^{*4}		-	20	-	
t _f	Turn-Off Fall Time ^{*4}		-	8	-	
Q _G	Total Gate-Charge	V _{DD} = -16V V _{GS} = -4.5V I _D = -1.5A	-	3.5	-	nC
Q _{GS}	Gate to Source Charge		-	0.7	-	
Q _{GD}	Gate to Drain (Miller) Charge		-	0.8	-	
Source-Drain Diode Characteristics						
V _{SD}	Diode Forward Voltage ^{*2}	I _{SD} = -1.5A, V _{GS} = 0V	-	-	-1.1	V

Notes:

2. The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
3. The E_{AS} data shows Max. rating. N: The test condition is V_{DD} = 15V, V_{GS} = 10V, L = 0.1mH;
P: The test condition is V_{DD} = -15V, V_{GS} = -10V, L = 0.1mH
4. Guaranteed by design, not subject to production

Ratings and Characteristics Curves-Q₁ (@ T_A = 25°C unless otherwise specified)

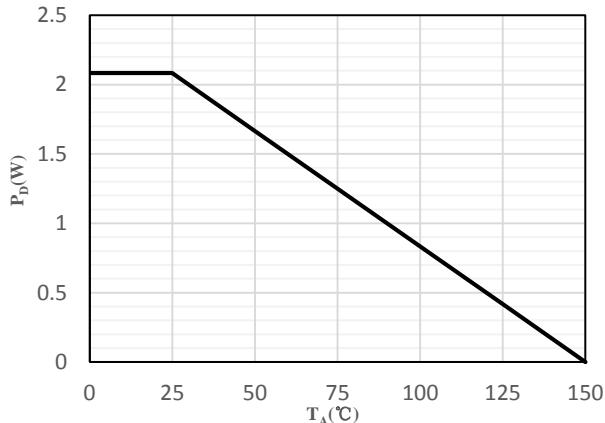


Fig 1 Power Dissipation

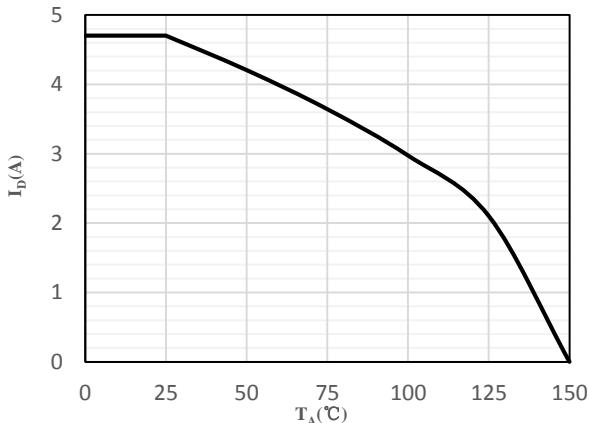


Fig 2 Drain Current

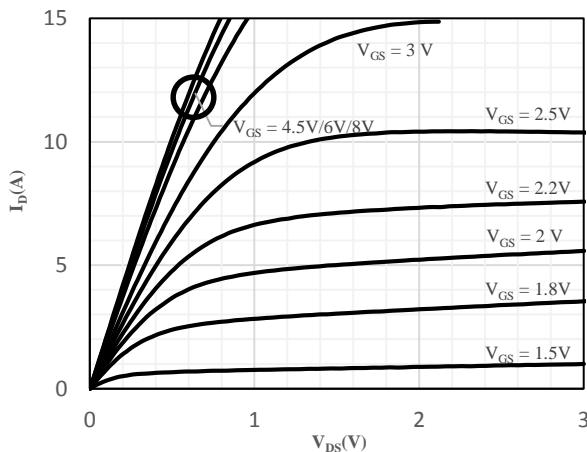


Fig 3 Typical Output Characteristics

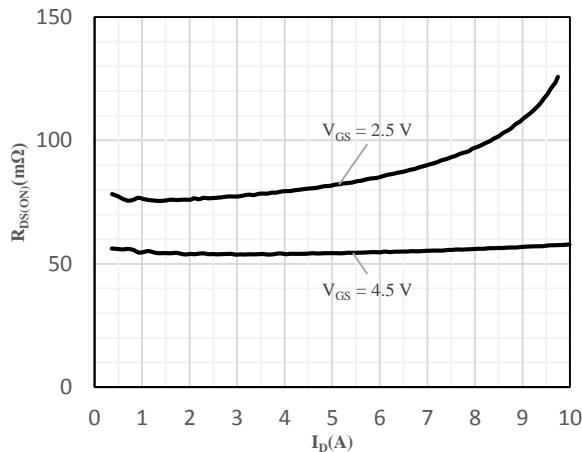


Fig 4 On-Resistance vs. Drain Current and Gate Voltage

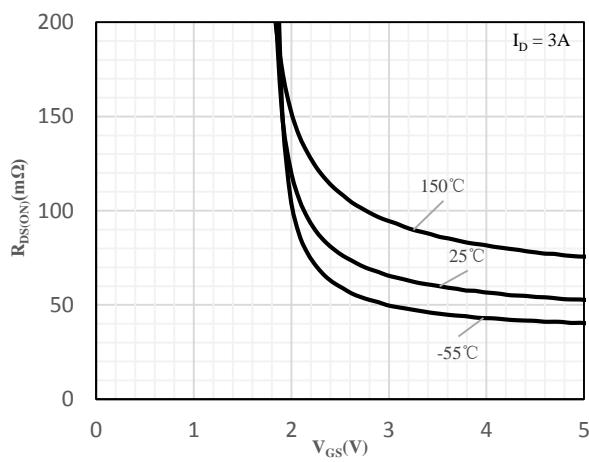


Fig 5 On-Resistance vs. Gate-Source Voltage

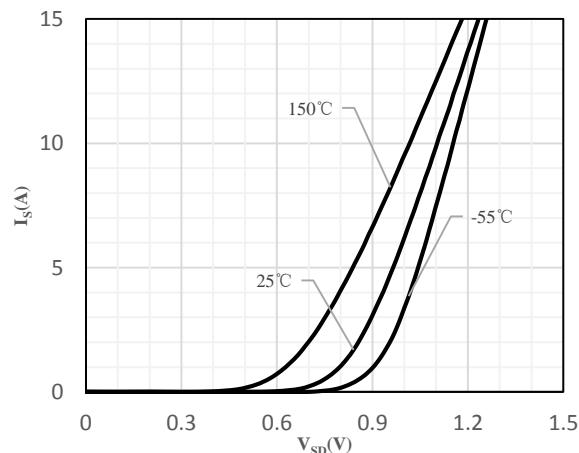


Fig 6 Body-Diode Characteristics

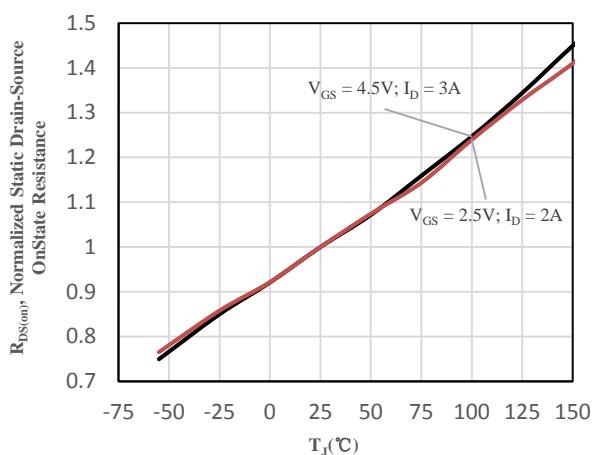


Fig 7 Normalized On-Resistance vs. Junction Temperature

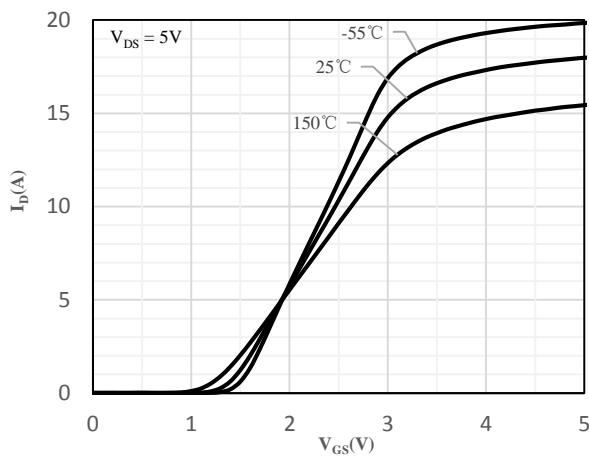


Fig 8 Transfer Characteristics

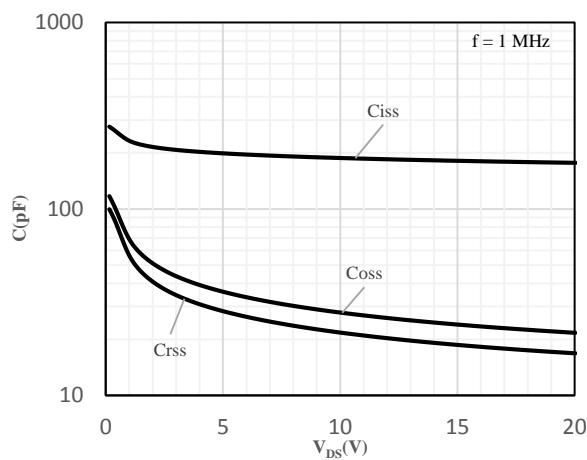


Fig 9 Capacitance Characteristics

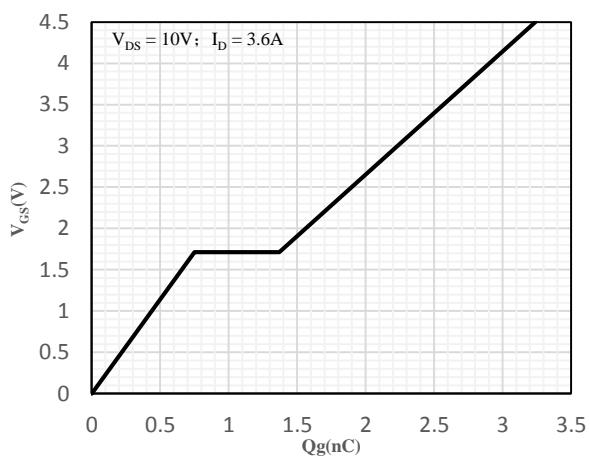


Fig 10 Gate-Charge Characteristics

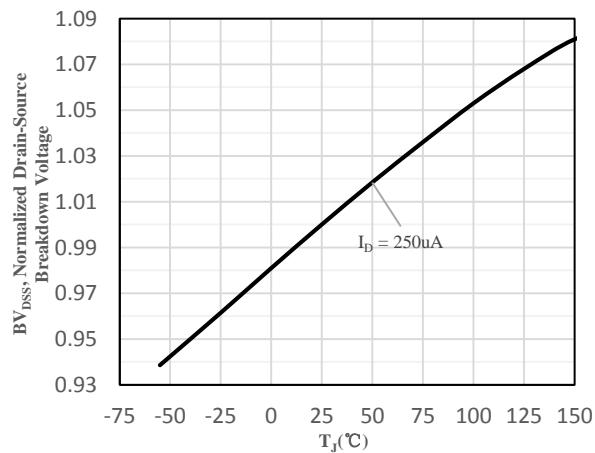


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

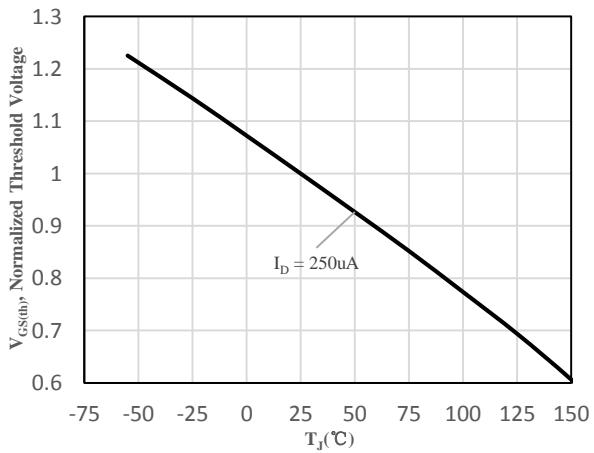


Fig 12 Normalized V_{GS(th)} vs. Junction Temperature

Ratings and Characteristics Curves-Q₂ (@ T_A = 25°C unless otherwise specified)

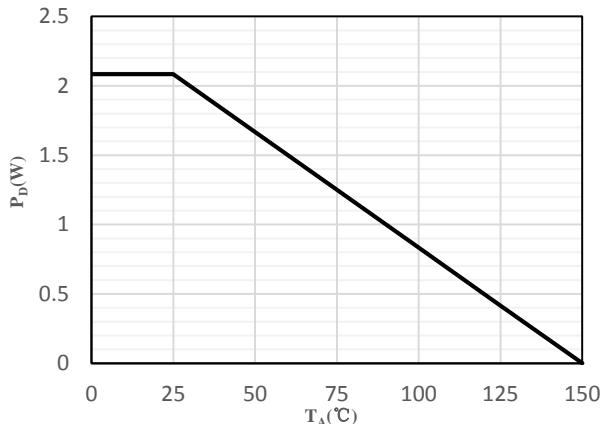


Fig 1 Power Dissipation

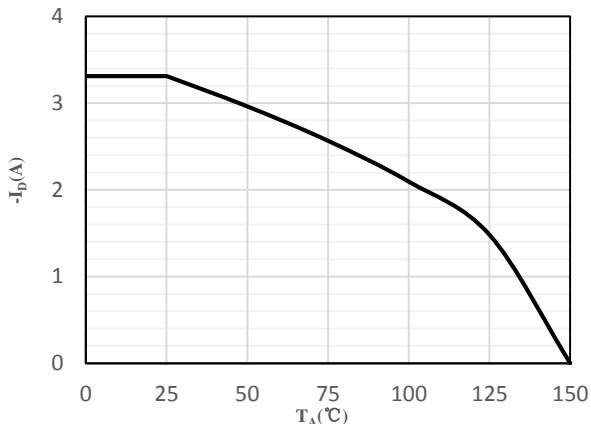


Fig 2 Drain Current

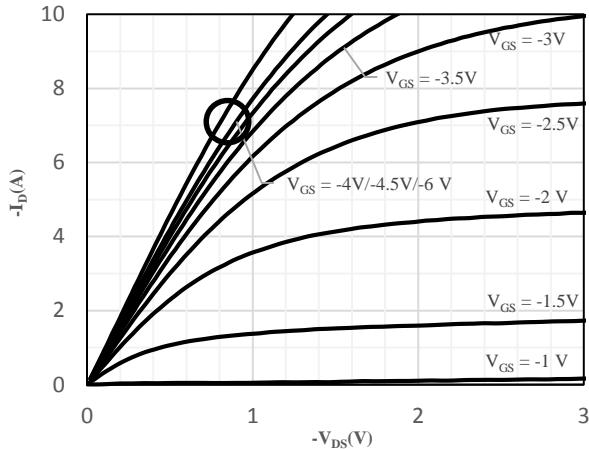


Fig 3 Typical Output Characteristics

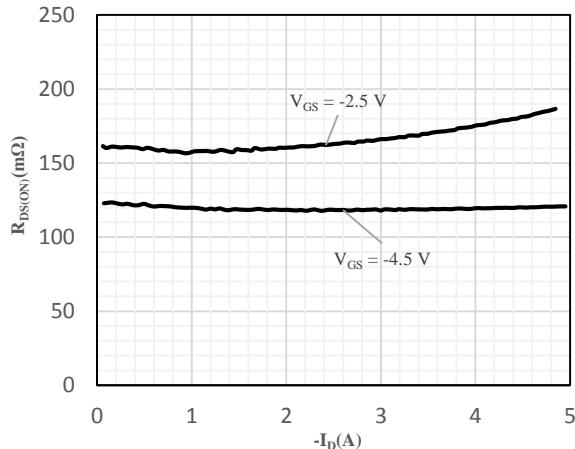


Fig 4 On-Resistance vs. Drain Current and Gate Voltage

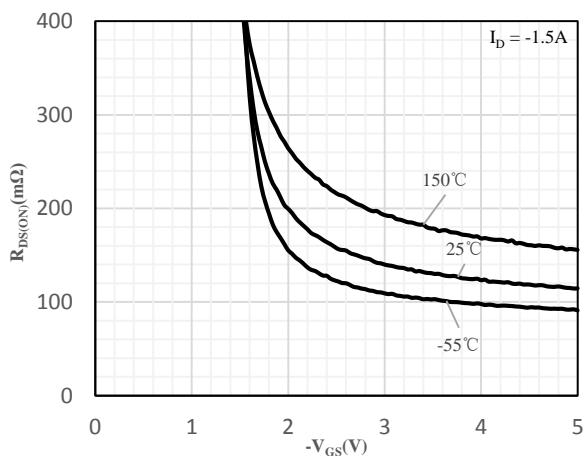


Fig 5 On-Resistance vs. Gate-Source Voltage

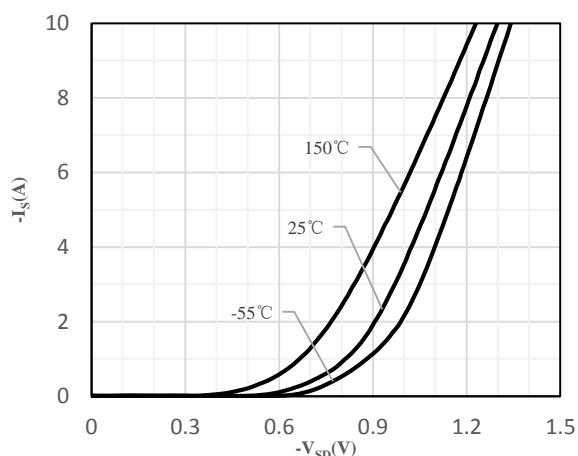


Fig 6 Body-Diode Characteristics

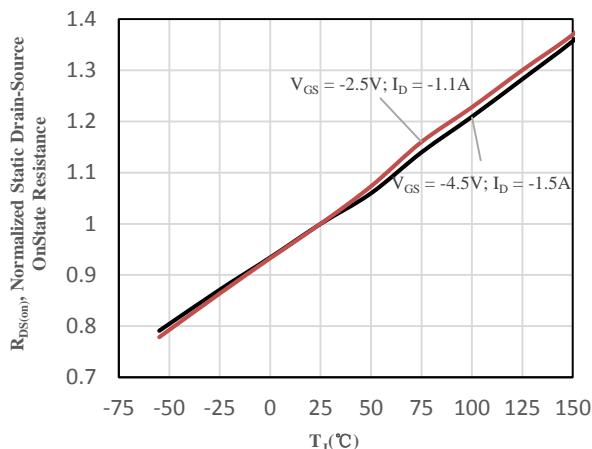


Fig 7 Normalized On-Resistance vs. Junction Temperature

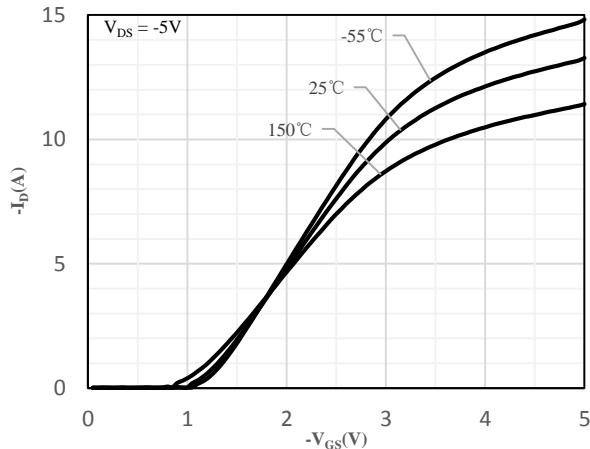


Fig 8 Transfer Characteristics

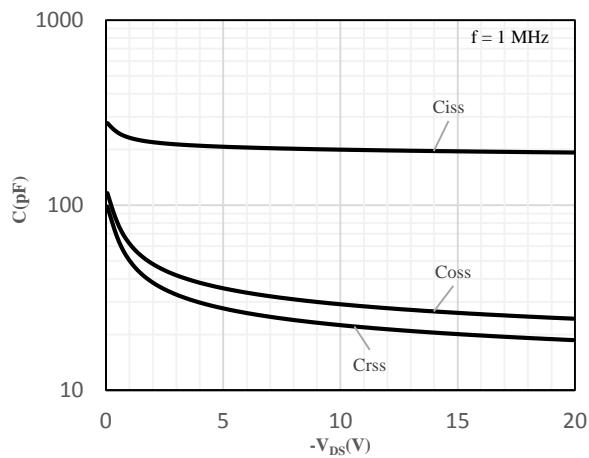


Fig 9 Capacitance Characteristics

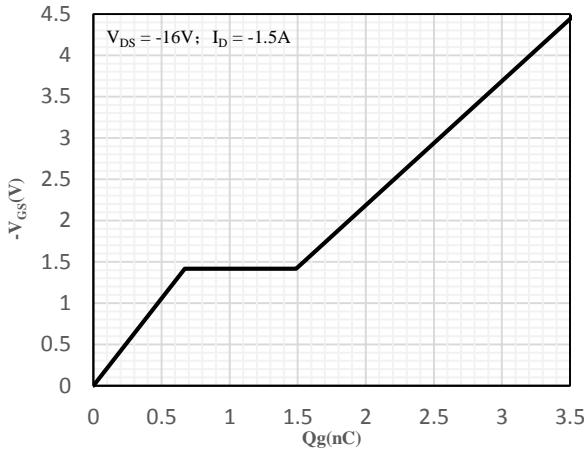


Fig 10 Gate-Charge Characteristics

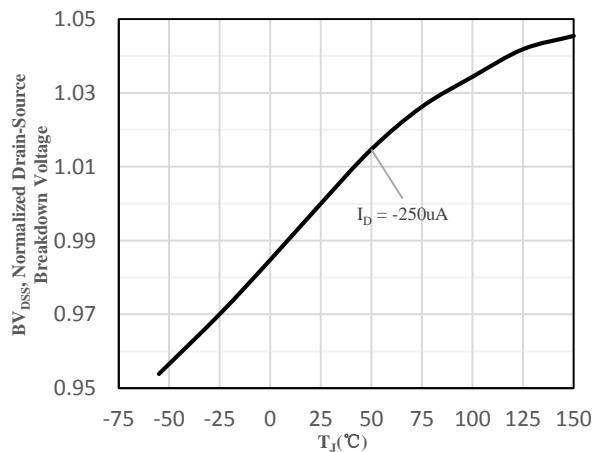


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

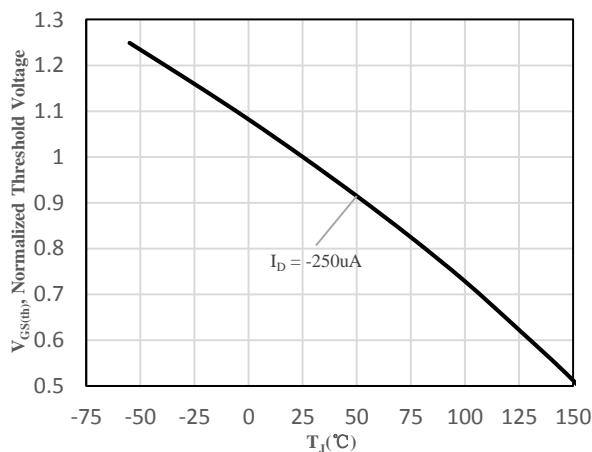
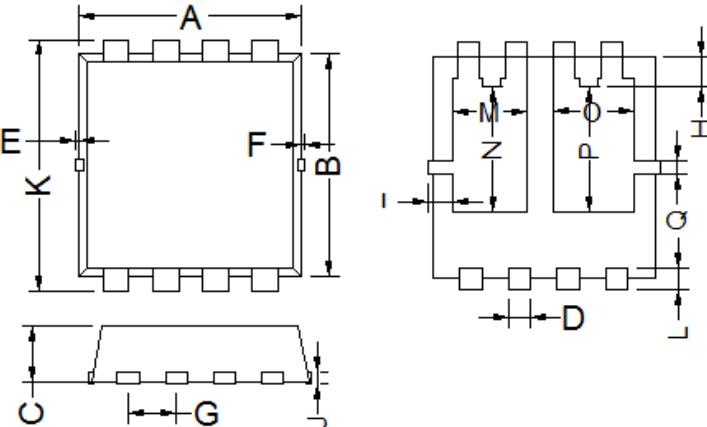


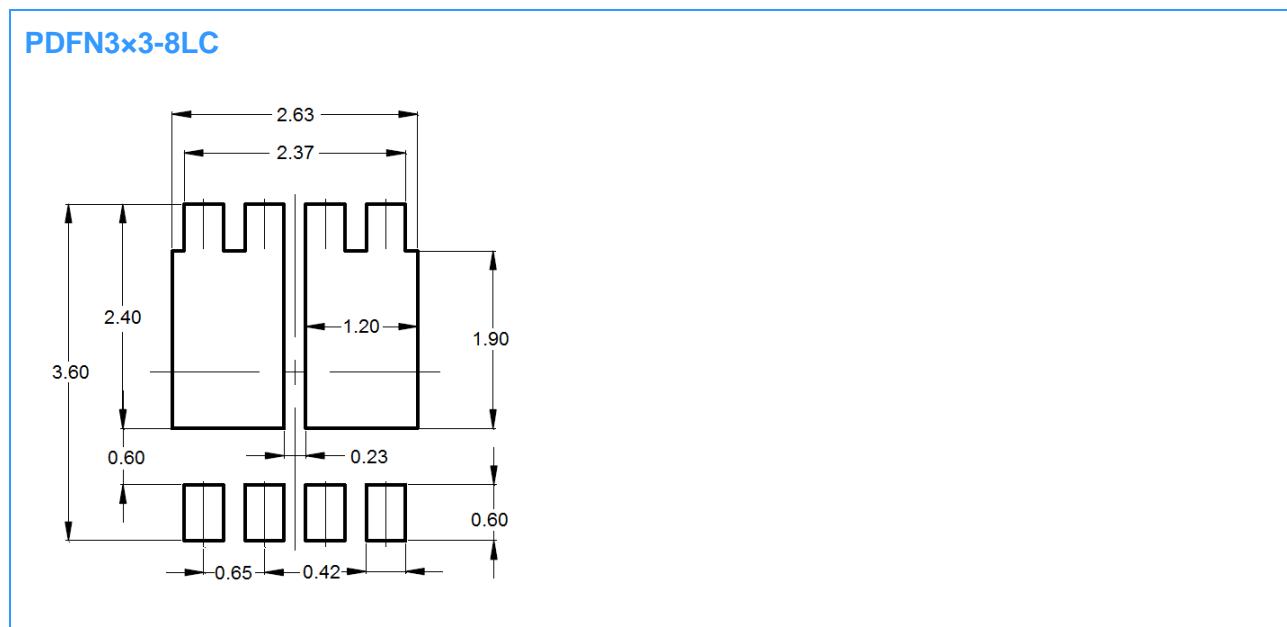
Fig 12 Normalized $V_{GS(th)}$ vs. Junction Temperature

Package Outline Dimensions (Unit: mm)



PDFN3x3-8LC		
Dimension	Min.	Max.
A	2.90	3.10
B	2.90	3.10
C	0.55	0.75
D	0.20	0.40
E	0.00	0.20
F	0.00	0.20
G	0.55	0.75
H	0.20	0.40
I	0.20	0.40
J	0.10	0.20
K	3.15	3.45
L	0.25	0.45
M/O	0.90	1.20
N/P	1.65	1.85
Q	0.10	0.30

Mounting Pad Layout (Unit: mm)



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